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- Can Be Used as a 4-Bit Digital Comparator
- Input Clamping Diodes Simplify System Design
- Fully Compatible with Most TTL Circuits

### **FUNCTION TABLE**

INP	UTS	OUTPUT
Α	В	Y
L	L	Н
L	Н	L.
н	L	L
н	Н	н

H = high level, L = low level

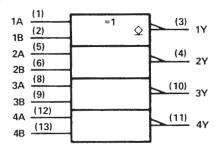
### description

The 'LS266 is comprised of four independent 2-input exclusive-NOR gates with open-collector outputs. The open-collector outputs permit tying outputs together for multiple-bit comparisons.

### logic symbol (each gate)



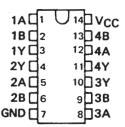
# logic symbol<sup>†</sup>



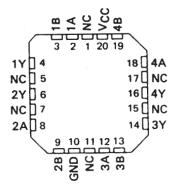
positive logic:  $Y = \overline{A \oplus B} = AB + \overline{AB}$ 

Pin numbers shown are for D, J, N, and W packages.

### SN54LS266 . . . J OR W PACKAGE SN74LS266 . . . D OR N PACKAGE (TOP VIEW)

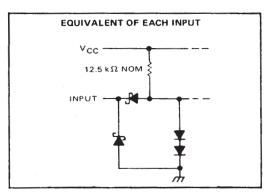


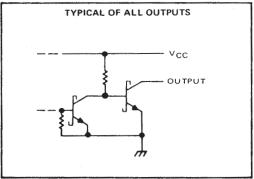
# SN54LS266 ... FK PACKAGE (TOP VIEW)



NC - No internal connection

## schematic of inputs and outputs







 $<sup>^\</sup>dagger$  This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

# SN54LS266, SN74LS266 QUADRUPLE 2-INPUT EXCLUSIVE-NOR GATES WITH OPEN-COLLECTOR OUTPUTS

SDLS151 – DECEMBER 1972 – REVISED MARCH 1988

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)					 									7 '	V
Input voltage															
Operating free-air temperature range:	SN54LS266		٠.		 						Ę	55°	C to	125°	С
	SN74LS266				 							0	°C 1	o 70°	С
Storage temperature range															

NOTE 1: Voltage values are with respect to network ground terminal.

### recommended operating conditions

	SI	N54LS2	66	SI	UNIT		
	MIN	NOM	MAX	MIN	NOM	MAX	ONT
Supply voltage, V <sub>CC</sub>	4.5	5	5.5	4.75	5	5.25	٧
High-level output voltage, VOH			5.5			5.5	٧
Low-level output current, IOL			4			8	mA
Operating free-air temperature, TA	-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		7507.004	TEST CONDITIONS†			66	S	UNIT		
		TEST CON	MIN	TYP <sup>‡</sup>	MAX	MIN	TYP‡	MAX	ONT	
VIH	High-level input voltage			2			2			٧
VIL	Low-level input voltage					0.7			0.8	V
VIK	Input clamp voltage	VCC = MIN,	I <sub>I</sub> = -18 mA			1.5			-1.5	٧
ЮН	High-level output current	V <sub>CC</sub> = MIN, V <sub>IL</sub> = V <sub>IL</sub> max,	V <sub>IH</sub> = 2 V, V <sub>OH</sub> = 5.5 V			100			100	μА
Vai	Low-level output voltage	V <sub>CC</sub> ≈ MIN, V <sub>IH</sub> = 2 V,	IOL = 4 mA		0.25	0.4		0.25	0.4	V
VOL	Low-level output voltage	VIL = VIL max	I <sub>OL</sub> = 8 mA					0.35	0.5	
- la	Input current at maximum input voltage	V <sub>CC</sub> = MAX,	V1 = 7 V			0.2			0.2	mA
Чн	High-level input current	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 2.7 V			40			40	μА
IL	Low-level input current	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 0.4 V			-0.8			-0.8	mA
1cc	Supply current	V <sub>CC</sub> = MAX,	See Note 2		8	13		8	13	mA

<sup>&</sup>lt;sup>1</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.  $^{\ddagger}$  All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25 C.

# switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

PARAMETER§	FROM (INPUT)	TEST COI	NDITIONS	MIN	TYP	MAX	UNIT	
<sup>t</sup> PLH	A or B	Other input low	$C_L = 15 pF$ , $R_L = 2 k\Omega$ , See Note 3		18	30	ns	
<sup>t</sup> PHL	7015	Other mpatiow				18	30	113
<sup>t</sup> PLH	A or B	Other input high			18	30	ns	
t <sub>PHL</sub>	7, 0, 0	Other inpat night	000 11010		18	30		

<sup>§</sup>tpLH = propagation delay time, low-to-high-level output



NOTE 2: 1<sub>CC</sub> is measured with one input of each gate at 4.5 V, the other inputs grounded, and the outputs open

tpHL = propagation delay time, high-to-low-level output

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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